LMN200B02

200 mA LOAD SWITCH FEATURING PRE-BIASED PNP TRANSISTOR AND N-MOSFET WITH GATE PULL DOWN RESISTOR

General Description

LMN200B02 is best suited for applications where the load needs to be turned on and off using control circuits like micro-controllers, comparators etc. particularly at a point of load. It features a discrete pass transistor with stable $V_{CE(SAT)}$ which does not depend on the input voltage and can support continuous maximum current of 200 mA . It also contains a discrete N-MOSFET that can be used as control. This N-MOSFET also has a built-in pull down resistor at its gate. The component can be used as a part of a circuit or as a stand alone discrete device.
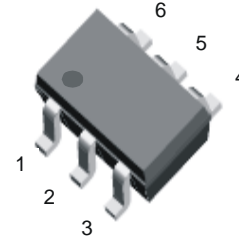
Features

- Voltage Controlled Small Signal Switch
- N-MOSFET with Gate Pull-Down Resistor
- Surface Mount Package
- Ideally Suited for Automated Assembly Processes
- **Lead Free By Design/RoHS Compliant (Note 1)**
- **"Green" Device (Note 2)**

Mechanical Data

- Case: SOT-363
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections: See Diagram
- Terminals: Finish - Matte Tin annealed over Alloy 42 leadframe. Solderable per MIL-STD-202, Method 208
- Marking Information: See Page 8
- Ordering Information: See Page 8
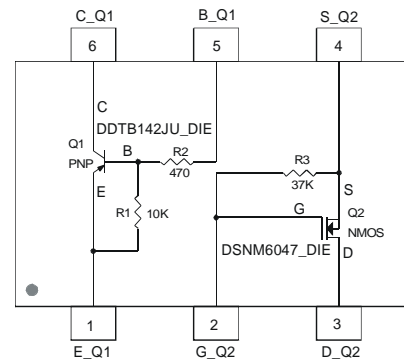- Weight: 0.006 grams (approximate)

Fig. 1: SOT-363

Fig. 2 Schematic and Pin Configuration

Sub-Component P/N	Reference	Device Type	R1 (NOM)	R2 (NOM)	R3 (NOM)	Figure
DDTB142JU_DIE	Q1	PNP Transistor	10K	470	—	2
DSNM6047_DIE (with Gate Pull-Down Resistor)	Q2	N-MOSFET	—	—	37K	2

Maximum Ratings, Total Device   @T_A = 25°C unless otherwise specified

Characteristic	Symbol	Value	Unit
Power Dissipation (Note 3)	P_D	200	mW
Power Derating Factor above 125°C	P_{der}	1.6	mW/°C
Output Current	I_{out}	200	mA

Thermal Characteristics   @T_A = 25°C unless otherwise specified

Characteristic	Symbol	Value	Unit
Operating and Storage Temperature Range	T_J, T_{STG}	-55 to +150	°C
Thermal Resistance, Junction to Ambient Air (Equivalent to One Heated Junction of PNP Transistor) (Note 3)	$R_{\theta JA}$	625	°C/W

Notes: 1. No purposefully added lead.
2. Diodes Inc.'s "Green" policy can be found on our website at http://www.diodes.com/products/lead_free/index.php.
3. Device mounted on FR-4 PCB, 1 inch x 0.85 inch x 0.062 inch; pad layout as shown on Diodes Inc. suggested pad layout document AP02001, which can be found on our website at http://www.diodes.com/datasheets/ap02001.pdf.

Maximum Ratings:
Sub-Component Device: Pre-Biased PNP Transistor (Q1) @T_A = 25°C unless otherwise specified

Characteristic	Symbol	Value	Unit
Collector-Base Voltage	V_{CBO}	-50	V
Collector-Emitter Voltage	V_{CEO}	-50	V
Supply Voltage	V_{CC}	-50	V
Input Voltage	V_{in}	+5 to -6	V
Output Current	I_C	-200	mA

Sub-Component Device: N-MOSFET With Gate Pull-Down Resistor (Q2) @T_A = 25°C unless otherwise specified

Characteristic		Symbol	Value	Unit
Drain-Source Voltage		V_{DSS}	60	V
Drain Gate Voltage ($R_{GS} \leq$ 1M Ohm)		V_{DGR}	60	V
Gate-Source Voltage	Continuous	V_{GSS}	+/-20	V
	Pulsed (tp<50 uS)		+/-40	
Drain Current (Page 1: Note 3)	Continuous (V_{gs} = 10V)	I_D	115	mA
	Pulsed (tp <10 uS, Duty Cycle <1%)		800	
Continuous Source Current		I_S	115	mA

Electrical Characteristics: Pre-Biased PNP Transistor (Q1)　@T$_A$ = 25°C unless otherwise specified

Characteristic	Symbol	Min	Typ	Max	Unit	Test Condition
OFF CHARACTERISTICS						
Collector-Base Cut Off Current	I$_{CBO}$	—	—	-100	nA	V$_{CB}$ = -50V, I$_E$ = 0
Collector-Emitter Cut Off Current	I$_{CEO}$	—	—	-500	nA	V$_{CE}$ = -50V, I$_B$ = 0
Emitter-Base Cut Off Current	I$_{EBO}$	—	-0.5	-1	mA	V$_{EB}$ = -5V, I$_C$ = 0
Collector-Base Breakdown Voltage	V$_{(BR)CBO}$	-50	—	—	V	I$_C$ = -10 uA, I$_E$ = 0
Collector-Emitter Breakdown Voltage	V$_{(BR)CEO}$	-50	—	—	V	I$_C$ = -2 mA, I$_B$ = 0
Input Off Voltage	V$_{I(OFF)}$	—	-0.55	-0.3	V	V$_{CE}$ = -5V, I$_C$ = -100uA
Output Voltage	V$_{OH}$	-4.9	—	—	V	V$_{CC}$ = -5V, V$_B$ = -0.05V, R$_L$ = 1K
Ouput Current (leakage current same as I$_{CEO}$)	I$_{O(OFF)}$	—	—	-500	nA	V$_{CC}$ = -50V, V$_I$ = 0V
ON CHARACTERISTICS						
Collector-Emitter Saturation Voltage	V$_{CE(SAT)}$	—	—	-0.15	V	I$_C$ = -10 mA, I$_B$ = -0.5 mA
		—	—	-0.2	V	I$_C$ = -50mA, I$_B$ = -5mA
		—	—	-0.2	V	I$_C$ = -20mA, I$_B$ = -1mA
		—	—	-0.25	V	I$_C$ = -100mA, I$_B$= -10mA
		—	—	-0.25	V	I$_C$ = -200mA, I$_B$= -10mA
		—	—	-0.3	V	I$_C$ = -200mA, I$_B$ = -20mA
Equivalent On-Resistance*	R$_{CE(SAT)}$	—	—	1.5	Ω	I$_C$ = -200mA, I$_B$ = -10mA
DC Current Gain	h$_{FE}$	60	150	—	—	V$_{CE}$ = -5V, I$_C$ = -20 mA
		60	215	—	—	V$_{CE}$ = -5V, I$_C$ = -50 mA
		60	245	—	—	V$_{CE}$ = -5V, I$_C$ = -100 mA
		60	250	—	—	V$_{CE}$ = -5V, I$_C$ = -200 mA
Input On Voltage	V$_{I(ON)}$	-2.45	-0.7	—	V	V$_O$ = -0.3V, I$_C$ = -2 mA
Output Voltage (equivalent to V$_{CE(SAT)}$ or V$_{O(ON)}$)	V$_{OL}$	—	-0.065	-0.15	V	V$_{CC}$ = -5V, V$_B$ = -2.5V, I$_o$/I$_I$ = -50mA /-2.5mA
Input Current	I$_i$	—	-9	-28	mA	V$_I$ = -5V
Base-Emitter Turn-on Voltage	V$_{BE(ON)}$	—	-1.13	-1.3	V	V$_{CE}$ = -5V, I$_C$ = 200mA
Base-Emitter Saturation Voltage	V$_{BE(SAT)}$	—	-3.2	-3.6	V	I$_C$ = -50mA, I$_B$ = -5mA
		—	-4.6	-5.5		I$_C$ = -80mA, I$_B$ = -8mA
Input Resistor (Base), +/- 30%	R2	—	0.47	—	KΩ	—
Pull-up Resistor (Base to Vcc supply), +/- 30%	R1	—	10	—	KΩ	—
Resistor Ratio (Input Resistor/Pull-up resistor) +/- 20%	R1/R2	—	21	—	—	—
SMALL SIGNAL CHARACTERISTICS						
Transition Frequency (Gain Bandwidth Product)	f$_T$	—	200	—	MHz	V$_{CE}$ = -10V, I$_E$ = -5mA, f = 100MHz
Collector Capacitance, (C$_{cbo}$-Output Capacitance)	C$_C$	—	20	—	pF	V$_{CB}$ = -10V, I$_E$ = 0A, f = 1MHz

 * Pulse Test: Pulse width, tp<300 μS, Duty Cycle, d<=0.02

Electrical Characteristics:
N-MOSFET with Gate Pull-Down Resistor (Q2)   @T$_A$ = 25°C unless otherwise specified

Characteristic	Symbol	Min	Typ	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 4)						
Drain-Source Breakdown Voltage, BV$_{DSS}$	V$_{(BR)DSS}$	60	—	—	V	V$_{GS}$ = 0V, I$_D$ = 10µA
Zero Gate Voltage Drain Current (Drain Leakage Current)	I$_{DSS}$	—	—	1	µA	V$_{GS}$ =0V, V$_{DS}$ = 60V
Gate-Body Leakage Current, Forward	I$_{GSSF}$	—	—	0.95	mA	V$_{GS}$ = 20V, V$_{DS}$ = 0V
Gate-Body Leakage Current, Reverse	I$_{GSSR}$	—	—	-0.95	mA	V$_{GS}$ = -20V, V$_{DS}$ = 0V
ON CHARACTERISTICS (Note 4)						
Gate Source Threshold Voltage (Control Supply Voltage)	V$_{GS(th)}$	1	1.9	2.2	V	V$_{DS}$ = V$_{GS}$, I$_D$ = 0.25mA
Static Drain-Source On-State Voltage	V$_{DS(on)}$	—	0.10	1.5	V	V$_{GS}$ = 5V, I$_D$ = 50mA
		—	0.15	3.75		V$_{GS}$ = 10V, I$_D$ = 115mA
On-State Drain Current	I$_{D(on)}$	500	—	—	mA	V$_{GS}$ = 10V, V$_{DS}$ ≥2xV$_{DS(ON)}$
Static Drain-Source On-Resistance	R$_{DS(on)}$	—	1.6	3	Ω	V$_{GS}$ = 5V, ID = 50mA
		—	1.4	2		V$_{GS}$ = 10V, ID = 500mA
Forward Transconductance	g$_{FS}$	80	240	—	mS	V$_{DS}$ ≥2xV$_{DS(ON)}$, I$_D$ = 115 mA
		80	350	—		V$_{DS}$ ≥2xV$_{DS(ON)}$, I$_D$ = 200 mA
Gate Pull-Down Resistor, +/- 30%	R3	—	37	—	KΩ	—
DYNAMIC CHARACTERISTICS						
Input Capacitance	C$_{iss}$	—	—	50	pF	V$_{DS}$ = -25V, V$_{GS}$ = 0V, f = 1MHz
Output Capacitance	C$_{oss}$	—	—	25	pF	
Reverse Transfer Capacitance	C$_{rss}$	—	—	5	pF	
SWITCHING CHARACTERISTICS						
Turn-On Delay Time	t$_{D(on)}$	—	—	20	ns	V$_{DD}$ = 30V, V$_{GS}$ =10V, I$_D$ = 200mA, R$_G$ = 25 Ohm, R$_L$ = 150 Ohm
Turn-Off Delay Time	t$_{D(off)}$	—	—	40	ns	
SOURCE-DRAIN (BODY) DIODE CHARACTERISTICS AND MAXIMUM RATINGS						
Drain-Source Diode Forward On-Voltage	V$_{SD}$	—	0.90	1.5	V	V$_{GS}$ = 0V, I$_S$ = 115 mA
Maximum Continuous Drain-Source Diode Forward Current (Reverse Drain Current)	I$_S$	—	—	115	mA	—
Maximum Pulsed Drain-Source Diode Forward Current	I$_{SM}$	—	—	800	mA	—

Notes: 4. Short duration pulse test used to minimize self-heating effect.

Typical Characteristics
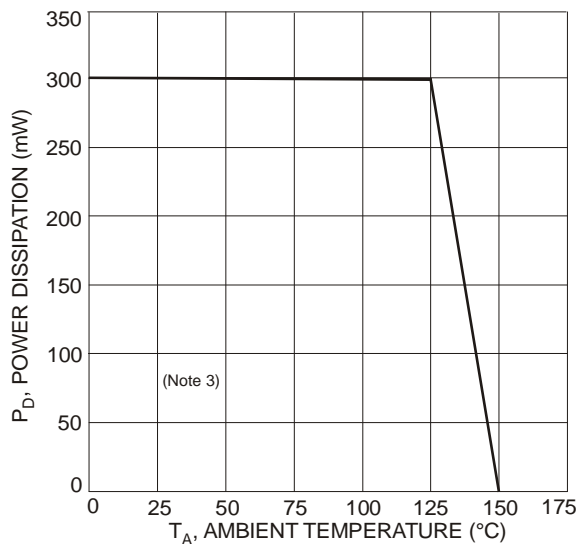

Fig. 3 Max Power Dissipation vs.
Ambient Temperature (Total Device)

Typical Pre-Biased PNP Transistor (Q1) Characteristics
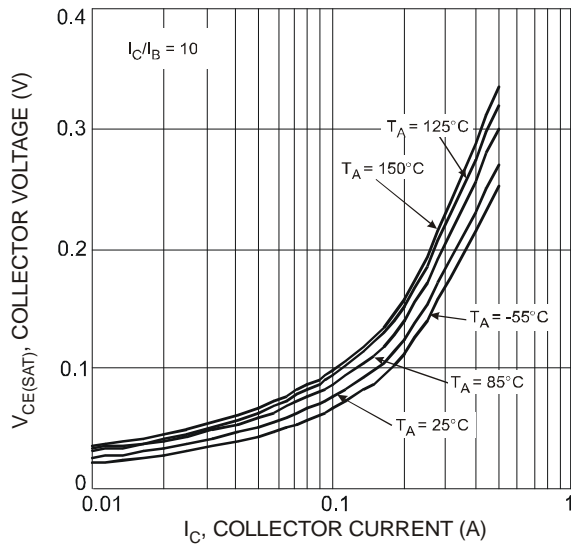
Fig. 4 V_{CE(SAT)} vs. I_C
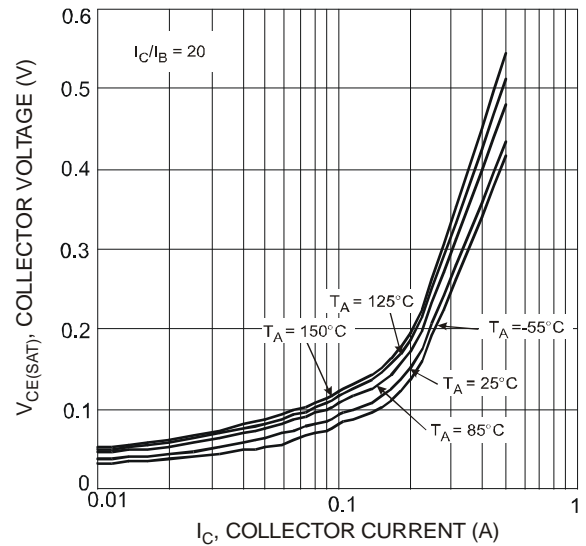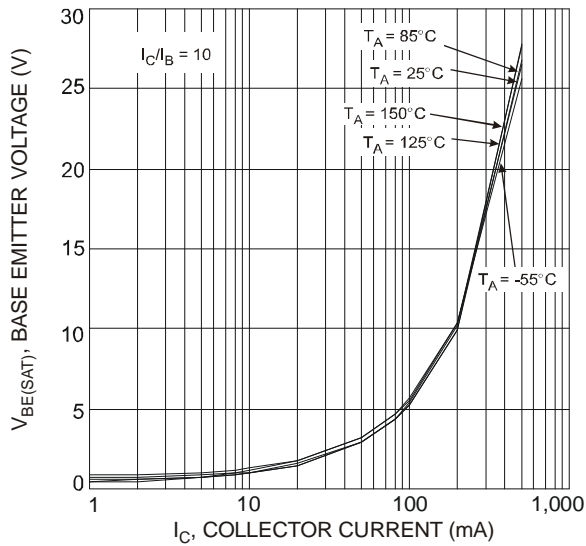
Fig. 5 V_{CE(SAT)} vs. I_C

Fig. 6 V_{BE(SAT)} vs. I_C
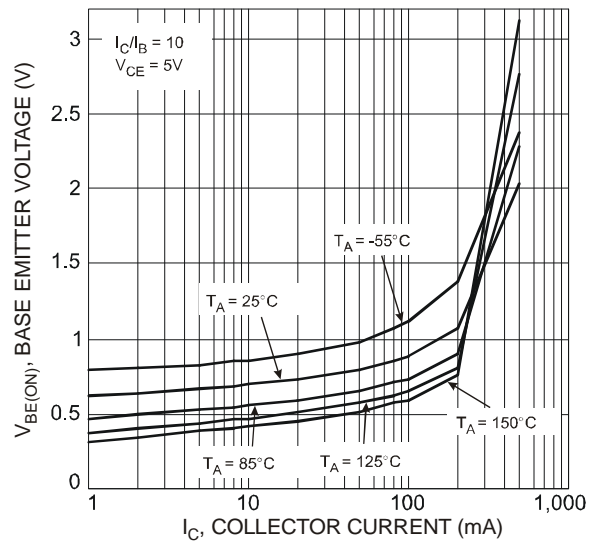
Fig. 7 V_{BE(ON)} vs. I_C
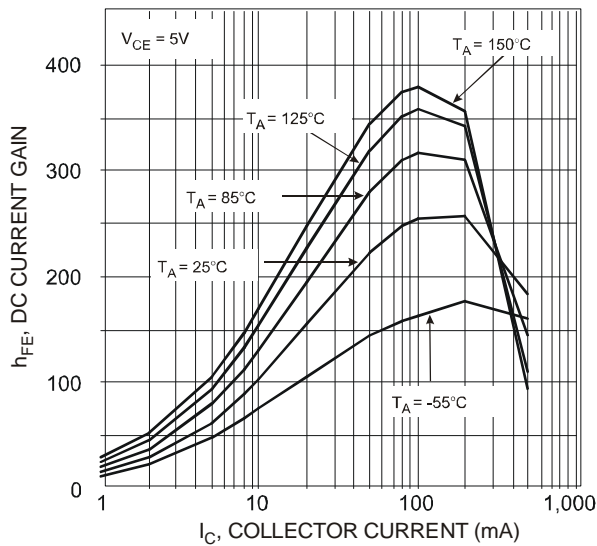
Fig. 8 h_{FE} vs. I_C

LMN200B02
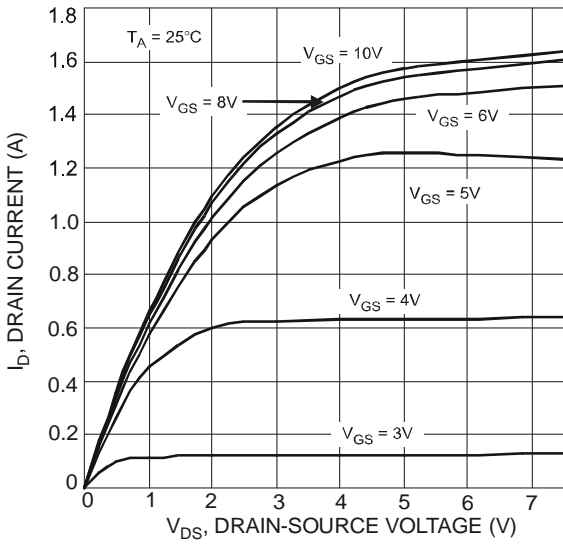
Typical N-Channel MOSFET (Q2) Characteristics
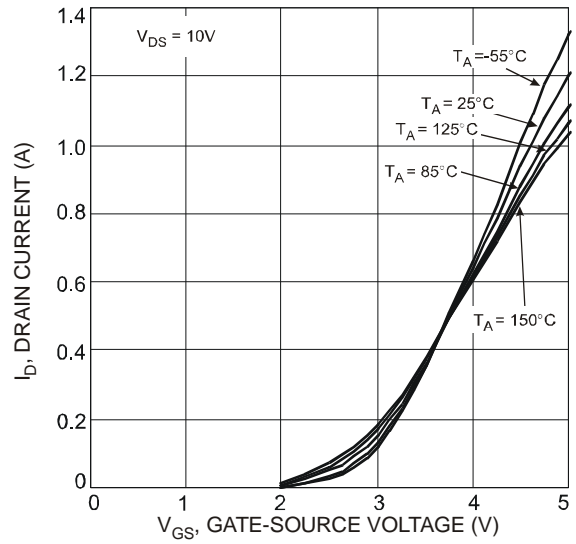

Fig. 9 Output Characteristics

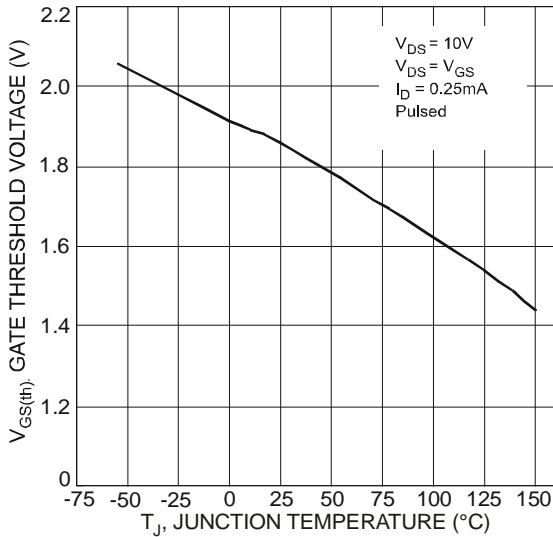

Fig. 10 Transfer Characteristics

Fig. 11 Gate Threshold Voltage
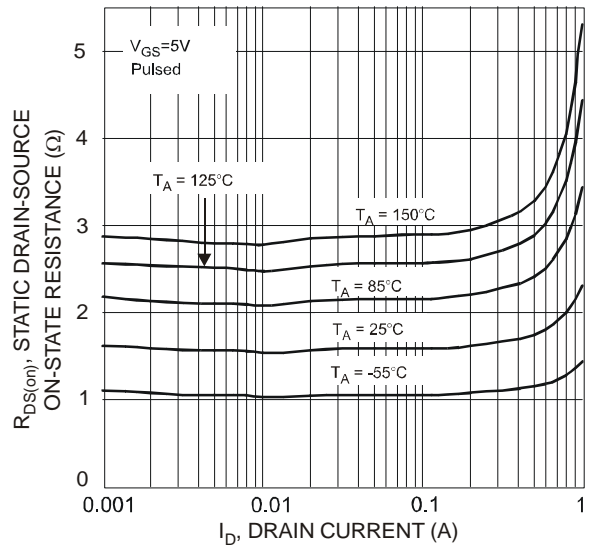vs. Junction Temperature

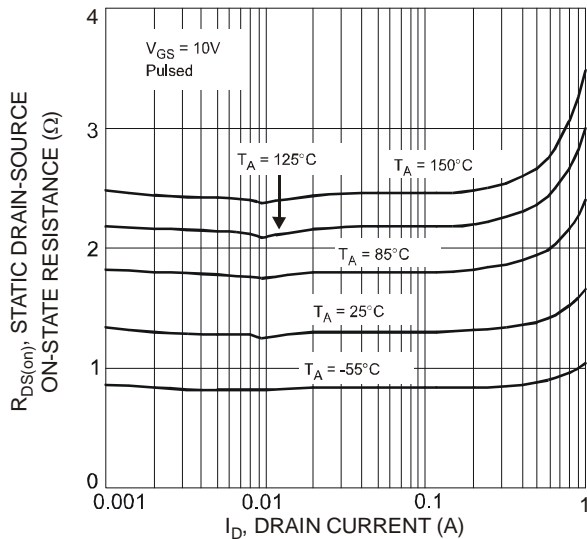Fig. 12 Static Drain-Source On-Resistance
vs. Drain Current

Fig. 13 Static Drain-Source On-Resistance
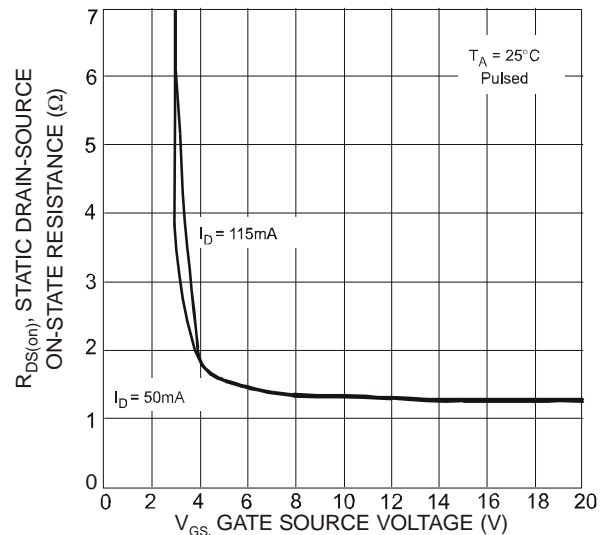vs. Drain Current

Fig. 14 Static Drain-Source On-Resistance
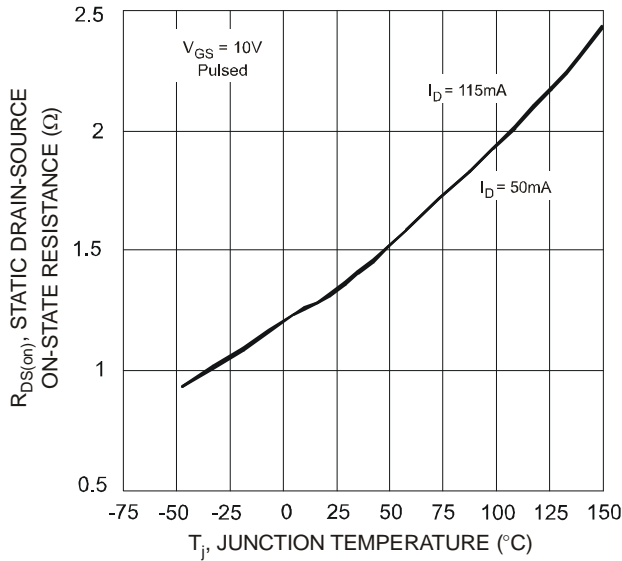vs. Gate-Source Voltage

Fig. 15 Static Drain-Source On-State Resistance
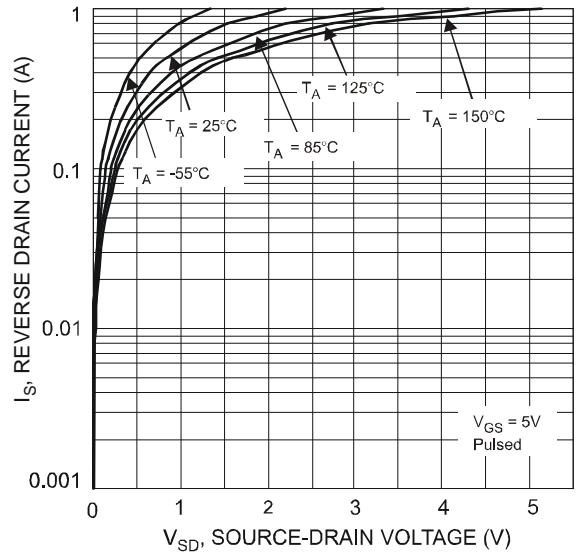vs. Junction Temperature

Fig. 16 Reverse Drain Current
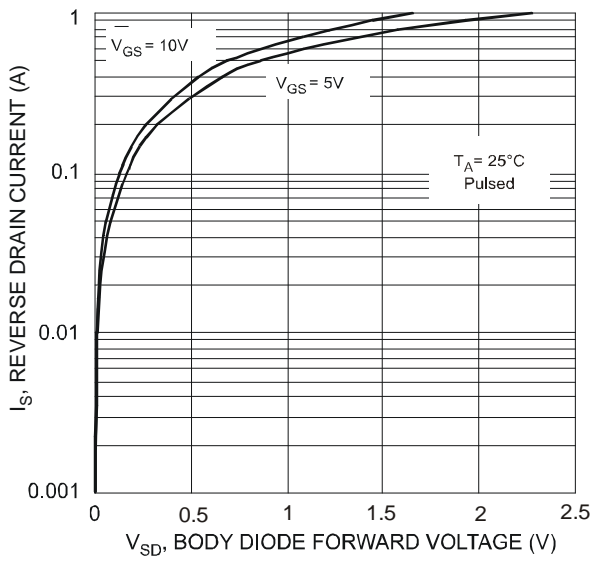vs. Source-Drain Voltage

Fig. 17 Reverse Drain Current
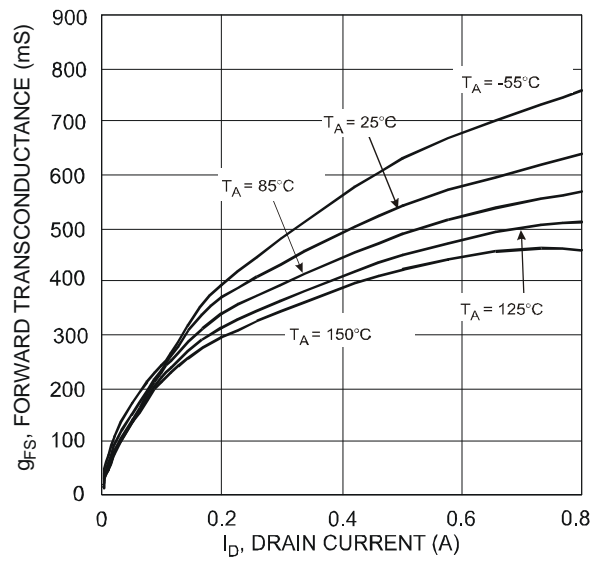vs. Body Diode Forward Voltage

Fig. 18 Forward Transfer Conductance
vs. Drain Current ($V_{DS} > I_D R_{DS(ON)}$)

Application Details

PNP Transistor (DDTB142JU) and N-MOSFET (DSNM6047) with gate pull-down resistor integrated as one in LMN200B02 can be used as a discrete entity for general purpose applications or as an integrated circuit to function as a Load Switch. When it is used as the latter as shown in Fig 19, various input voltage sources can be used as long as it does not exceed the maximum ratings of the device. These devices are designed to deliver continuous output load current up to a maximum of 200 mA. The MOSFET Switch draws no current, hence loading of control circuit is prevented. Care must be taken for higher levels of dissipation while designing for higher load conditions. These devices provide high power and also consume less space. The product mainly helps in optimizing power usage, thereby conserving battery life in a controlled load system like portable battery powered applications. (Please see Fig. 20 for one example of a typical application circuit used in conjunction with voltage regulator as a part of a power management system)
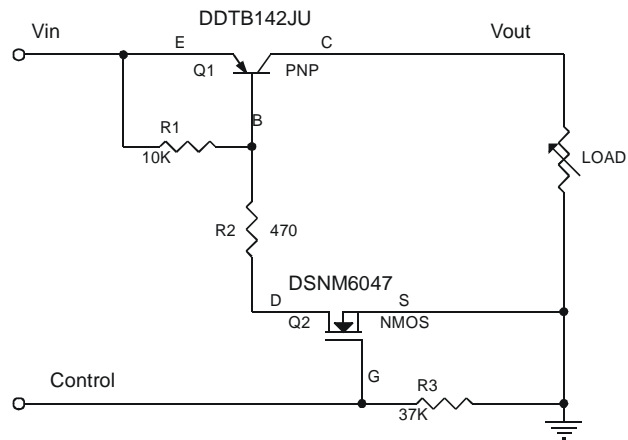
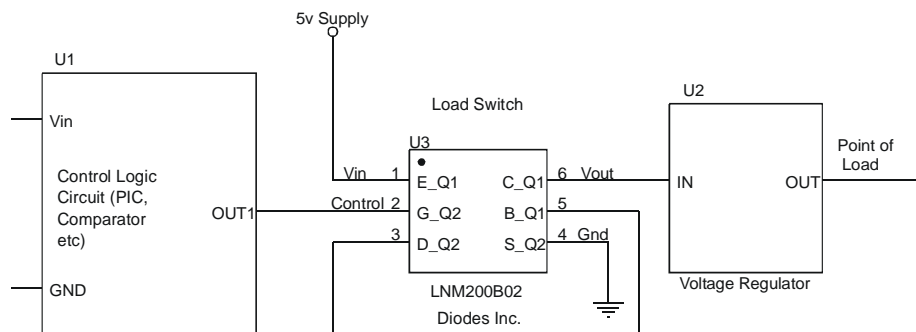Fig. 19 Circuit Diagram

Typical Application Circuit

Fig. 20

Ordering Information   (Note 5)

Device	Packaging	Shipping
LMN200B02-7	SOT-363	3000/Tape & Reel

Notes: 5.   For packaging details, go to our website at http://www.diodes.com/datasheets/ap02007.pdf.

Marking Information
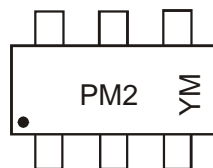
PM2 = Product Type Marking Code,
YM = Date Code Marking
Y = Year (ex: T = 2006)
M = Month (ex: 9 = September)

PM2   YM

Date Code Key

Year	2006	2007	2008	2009	2010	2011	2012	2013	2014	2015
Code	T	U	V	W	X	Y	Z	A	B	C

Month	Jan	Feb	Mar	Apr	May	Jun	Jul	Aug	Sep	Oct	Nov	Dec
Code	1	2	3	4	5	6	7	8	9	O	N	D

Mechanical Details
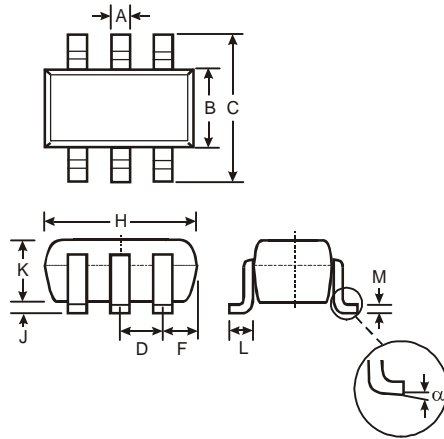
SOT-363		
Dim	**Min**	**Max**
A	0.10	0.30
B	1.15	1.35
C	2.00	2.20
D	0.65 Typ	
F	0.40	0.45
H	1.80	2.20
J	0	0.10
K	0.90	1.00
L	0.25	0.40
M	0.10	0.22
α	0°	8°
All Dimensions in mm		

Suggested Pad Layout
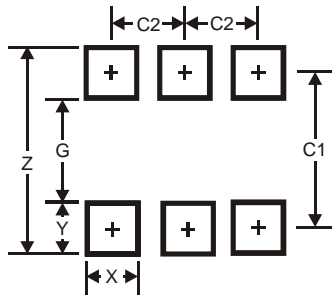
Dimensions	Value (in mm)
Z	2.5
G	1.3
X	0.42
Y	0.6
C1	1.9
C2	0.65

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